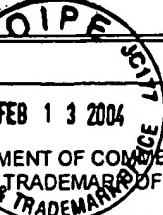


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FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY DOCKET NO. 2001_1036	SERIAL NO. NEW			
LIST OF REFERENCES CITED BY APPLICANT(S) <i>(Use several sheets if necessary)</i>			APPLICANT Shinichi SAEKI et al.				
Date Submitted to PTO: July 24, 2001			FILING DATE July 24, 2001	GROUP			
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>RL</i>	AA	5,642,338	06-24-97	Fukushima et al.			
<i>RL</i>	AB	5,617,407	04-01-97	Bareis			
<i>RL</i>	AC	4,777,537	10-11-88	Ueno et al.			
<i>RL</i>	AD	5,552,896	09-03-96	Yoshida			
<i>RL</i>	AE	6,078,727	6-20-00	Saeki et al.			
<i>RL</i>	AF	6,185,365	2-6-01	Murase et al			
<i>RL</i>	AG	6,167,189	12-26-00	Taira et al.			
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
<i>RL</i>	AH	0724264A2	07-31-96	Europe			
<i>RL</i>	AI	0695098A2	01-31-96	Europe			
<i>RL</i>	AJ	0752705A2	01-08-97	Europe			
<i>RL</i>	AK	0729153A2	08-28-96	Europe			
<i>RL</i>	AL	0797204A2	09-24-97	Europe			
	AM						
	AN						
	AO						
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
	AP						
	AQ						
EXAMINER	<i>Robert Chalas</i>			DATE CONSIDERED	<i>7/26/06</i>		

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FORM PTO 1449 (modified) FEB 13 2004		ATTY DOCKET NO. 2001_1036	SERIAL NO. 09/910,803				
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE							
LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)							
Date Submitted to PTO: February 13, 2004		APPLICANT Shinichi SAEKI et al.	FILING DATE July 24, 2001				
GROUP 2615							
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
RECEIVED							
FEB 18 2004							
Technology Center 2600							
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
<i>RC</i>	AJ	0 676 756	10-11-95	Europe	<i>✓</i>	<i>✓</i>	X
<i>RL</i>	AK	97/03443	1-30-97	WO	<i>✓</i>	<i>✓</i>	X
	AL						
	AM						
	AN						
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
	AO						
	AP						
	AQ						
EXAMINER	<i>Robert Dharwadkar</i>			DATE CONSIDERED	<i>2/21/06</i>		

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